NOTES:

1. SUBSTRATE:

Silicon (Si)

2. CENTERING TOLERANCE:

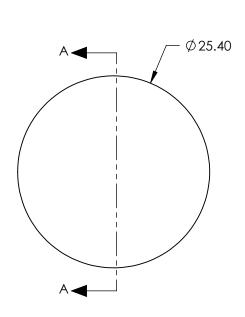
EDGE THICKNESS VARIATION: <20µm

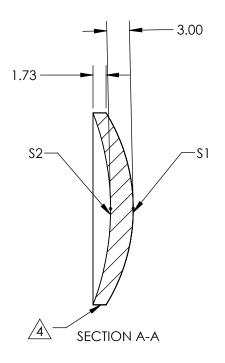
3. COATING (APPLY ACROSS CLEAR APERTURE)

\$1&\$2: R(AVG) <0.5% @ 3 - 5µm R(ABS) <1.5% @ 3 - 5µm



5. SURFACE ROUGNESS: <100 Ra





FOR INFORMATION ONLY: DO NOT MANUFACTURE PARTS TO THIS DRAWING

SPECIFICATIONS SUBJECT TO CHANGE WITHOUT NOTICE DIMENSIONS ARE FOR REFERENCE ONLY

	\$1	S2
SHAPE	CONVEX	CONCAVE
RADIUS	24.00	35.84
SURFACE QUALITY	60-40	60-40
CLEAR APERTURE	ø22.86	ø22.86
IRREGULARITY AT 632.8nm	λ/4	λ/4
BEVEL	PROTECTED AS NEEDED	PROTECTED AS NEEDED

e	®	Edmund	Optics®

THIRD ANGLE PROJECTION	THIRD ANGLE	TITLE	25.4mm Dia. x 25.4mm FL, 3 - 5µm BBAR
	PROJECTION PROJECTION		Coated, ISP Optics Silicon (Si) Aspheric Lens

ALL DIMS IN	mm	DWG NO	24885	SHEET 5 OF 1